

10-Tap Silicon Delay Line

DS1110

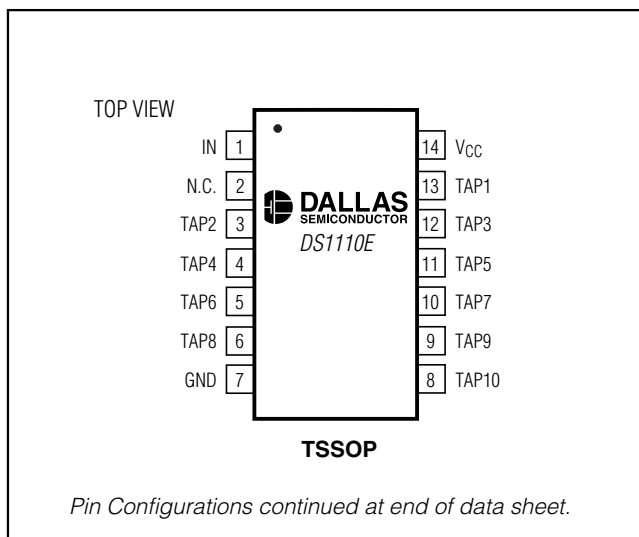
General Description

The DS1110 delay line is an improved replacement for the DS1010. It has ten equally spaced taps providing delays from 5ns to 500ns. The devices are offered in a standard 16-pin SO or 14-pin TSSOP. The DS1110 series delay lines provide a nominal accuracy of $\pm 5\%$ or $\pm 2\text{ns}$, whichever is greater, at 5V and $+25^\circ\text{C}$. The DS1110 reproduces the input logic state at the tap 10 output after a fixed delay as specified by the dash number extension of the part number. The DS1110 is designed to produce both leading- and trailing-edge delays with equal precision. Each tap is capable of driving up to ten 74LS type loads. Dallas Semiconductor can customize standard products to meet special needs.

Applications

- Communications Equipment
- Medical Devices
- Automated Test Equipment
- PC Peripheral Devices

Pin Configurations



Features

- ◆ All-Silicon, 5V, 10-Tap Delay Line
- ◆ Improved, Drop-In Replacement for the DS1010
- ◆ 10 Taps Equally Spaced
- ◆ Delays are Stable and Precise
- ◆ Leading- and Trailing-Edge Accuracy
- ◆ Delay Tolerance $\pm 5\%$ or $\pm 2\text{ns}$, whichever is Greater, at 5V and $+25^\circ\text{C}$
- ◆ Economical
- ◆ Auto-Insertable, Low Profile
- ◆ Low-Power CMOS
- ◆ TTL/CMOS Compatible
- ◆ Vapor Phase, IR, and Wave Solderable
- ◆ Fast-Turn Prototypes
- ◆ Delays Specified Over Commercial and Industrial Temperature Ranges
- ◆ Custom Delays Available
- ◆ Standard 16-Pin SO or 14-Pin TSSOP

Ordering Information

| PART | TEMP RANGE | PIN-PACKAGE |
|-------------|----------------|-------------|
| DS1110E-XXX | -40°C to +85°C | 14 TSSOP |
| DS1110S-XXX | -40°C to +85°C | 16 SO |

Selector Guide appears at end of data sheet.

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ABSOLUTE MAXIMUM RATINGS

Voltage on Any Pin Relative to Ground-0.5V to +6.0V
 Operating Temperature Range-40°C to +85°C

Storage Temperature Range-55°C to +125°C
 Soldering Temperature.....See IPC/JEDEC J-STD-020A

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

DC ELECTRICAL CHARACTERISTICS

($V_{CC} = 5.0V \pm 5\%$, $T_A = -40^\circ C$ to $+85^\circ C$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|---------------------------|----------|---|------|-----|----------------|---------|
| Supply Voltage | V_{CC} | (Note 1) | 4.75 | 5.0 | 5.25 | V |
| High-Level Input Voltage | V_{IH} | (Note 1) | 2.4 | | $V_{CC} + 0.3$ | V |
| Low-Level Input Voltage | V_{IL} | (Note 1) | -0.3 | | +0.8 | V |
| Input Leakage Current | I_I | $0V \leq V_I \leq V_{CC}$ | -1.0 | | +1.0 | μA |
| Active Current | I_{CC} | $V_{CC} = \text{max}$, period = min (Note 2) | | 40 | 150 | mA |
| High-Level Output Current | I_{OH} | $V_{CC} = \text{min}$, $V_{OH} = 2.3V$ | | | -1.0 | mA |
| Low-Level Output Current | I_{OL} | $V_{CC} = \text{min}$, $V_{OL} = 0.5V$ | 12 | | | mA |

AC ELECTRICAL CHARACTERISTICS

($V_{CC} = 5.0V \pm 5\%$, $T_A = -40^\circ C$ to $+85^\circ C$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|---|------------------------|-----------------------------------|---|---------|-----|-------|
| Input Pulse Width | t_{WI} | (Note 6) | 10% of tap 10 | | | ns |
| Input-to-Tap Delay (Delays $\leq 40ns$) | t_{PLH} t_{PHL} | +25°C, 5.0V (Notes 3, 5, 6, 7, 9) | -2 | Table 1 | +2 | ns |
| | | 0°C to +70°C (Notes 4-7) | -3 | Table 1 | +3 | |
| | | -40°C to +85°C (Notes 4-7) | -4 | Table 1 | +4 | |
| Input-to-Tap Delay (Delays > 40ns) | t_{PLH} t_{PHL} | +25°C, 5.0V (Notes 3, 5, 6, 7, 9) | -5 | Table 1 | +5 | % |
| | | 0°C to +70°C (Notes 4-7) | -8 | Table 1 | +8 | |
| | | -40°C to +85°C (Notes 4-7) | -13 | Table 1 | +13 | |
| Power-Up Time | t_{PU} | | | | 200 | ms |
| Input Period | Period | (Note 8) | 2(t_{WI}) or 20, whichever is greater | | | ns |

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CAPACITANCE

($T_A = +25^\circ\text{C}$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|-------------------|----------|------------|-----|-----|-----|-------|
| Input Capacitance | C_{IN} | | | 5 | 10 | pF |

Note 1: All voltages are referenced to ground.

Note 2: Measured with outputs open.

Note 3: Initial tolerances are \pm with respect to the nominal value at $+25^\circ\text{C}$ and $V_{CC} = 5.0\text{V}$ for both leading and trailing edges.

Note 4: Temperature and voltage tolerances are with respect to the actual delay measured over stated temperature range and a 4.75V to 5.25V range.

Note 5: Intermediate delay values are available on a custom basis.

Note 6: See *Test Conditions* section.

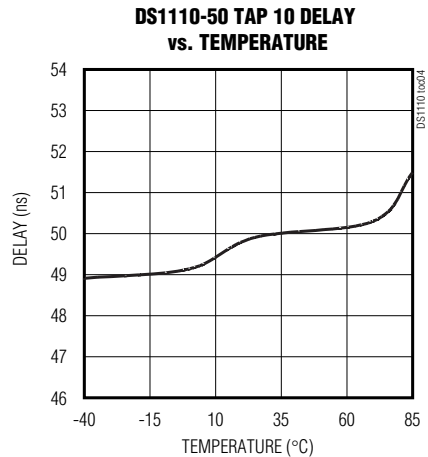
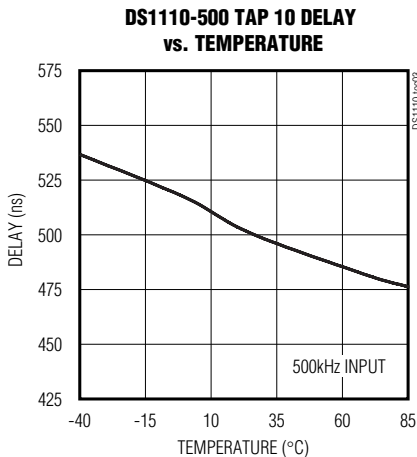
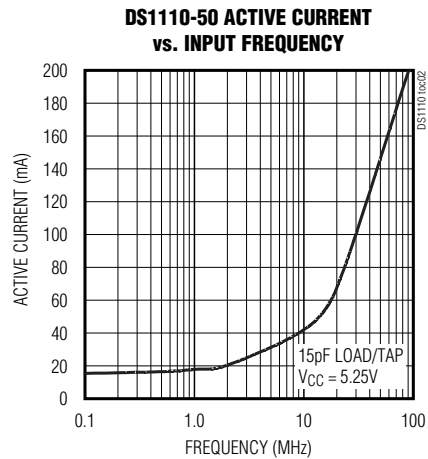
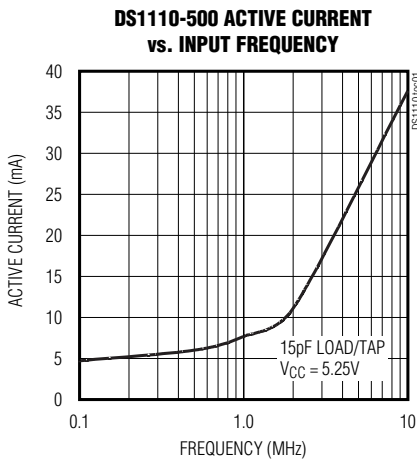
Note 7: All tap delays tend to vary unidirectionally with temperature or voltage changes. For example, if tap 1 slows down, all other taps also slow down; tap 3 can never be faster than tap 2.

Note 8: Pulse width and period specifications may be exceeded; however, accuracy is application sensitive (decoupling, layout, etc.)

Note 9: For Tap 1 delays greater than 20ns, the tolerance is $\pm 3\text{ns}$ or $\pm 5\%$, whichever is greater.

Typical Operating Characteristics

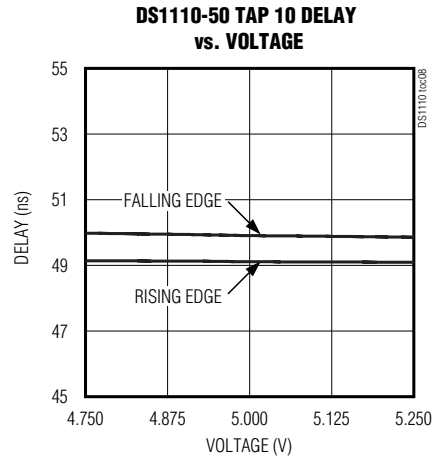
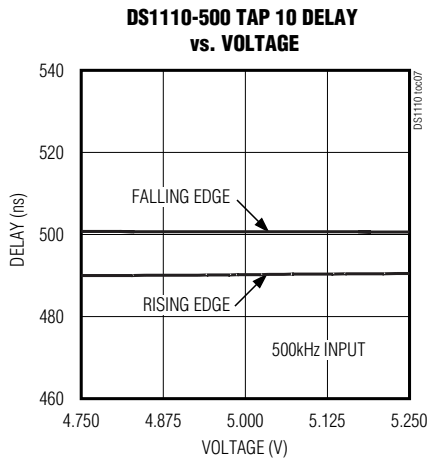
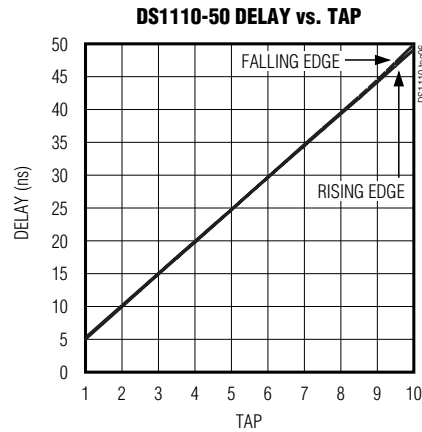
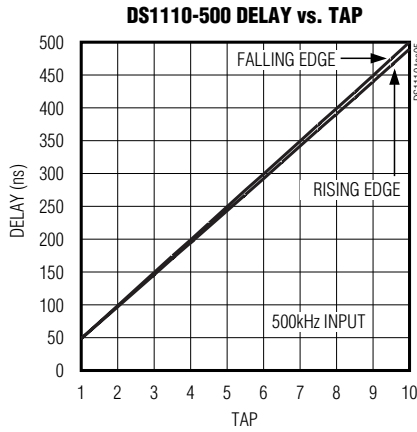
($V_{CC} = 5.0\text{V}$, $T_A = +25^\circ\text{C}$, unless otherwise noted.)



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Typical Operating Characteristics (continued)

(V_{CC} = 5.0V, T_A = +25°C, unless otherwise noted.)



Pin Description

| PIN | | NAME | FUNCTION |
|-------------------------------------|--------------------------------------|-----------------|-------------------|
| TSSOP | SO | | |
| 1 | 1 | IN | Input |
| 2 | 2, 3, 15 | N.C. | No Connection |
| 7 | 8 | GND | Ground |
| 13, 3, 12, 4, 11, 5, 10, 6, 9, 8 | 14, 4, 13, 5, 12, 6, 11, 7, 10, 9 | Tap 1–Tap 10 | Tap Output Number |
| 14 | 16 | V _{CC} | 5.0V |

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Detailed Description

The DS1110 delay line is an improved replacement for the DS1010. It has ten equally spaced taps providing delays from 5ns to 500ns. The devices are offered in a standard 16-pin SO or 14-pin TSSOP. The DS1110 series delay lines provide a nominal accuracy of $\pm 5\%$ or $\pm 2\text{ns}$, whichever is greater, at 5V and $+25^\circ\text{C}$. The DS1110 reproduces the input logic state at the tap 10 output after a fixed delay as specified by the dash number extension of the part number. The DS1110 is designed to produce both leading- and trailing-edge delays with equal precision. Each tap is capable of driving up to ten 74LS type loads. Dallas Semiconductor can customize standard products to meet special needs. For special requests call 972-371-4348.

Table 1. Part Number by Delay (t_{PHL} , t_{PLH})

| PART | TOTAL DELAY* (ns) | DELAY/TAP (ns) |
|------------|-------------------|----------------|
| DS1110-50 | 50 | 5 |
| DS1110-60 | 60 | 6 |
| DS1110-75 | 75 | 7.5 |
| DS1110-80 | 80 | 8 |
| DS1110-100 | 100 | 10 |
| DS1110-125 | 125 | 12.5 |
| DS1110-150 | 150 | 15 |
| DS1110-175 | 175 | 17.5 |
| DS1110-200 | 200 | 20 |
| DS1110-250 | 250 | 25 |
| DS1110-300 | 300 | 30 |
| DS1110-350 | 350 | 35 |
| DS1110-400 | 400 | 40 |
| DS1110-450 | 450 | 45 |
| DS1110-500 | 500 | 50 |

*Custom delays are available.

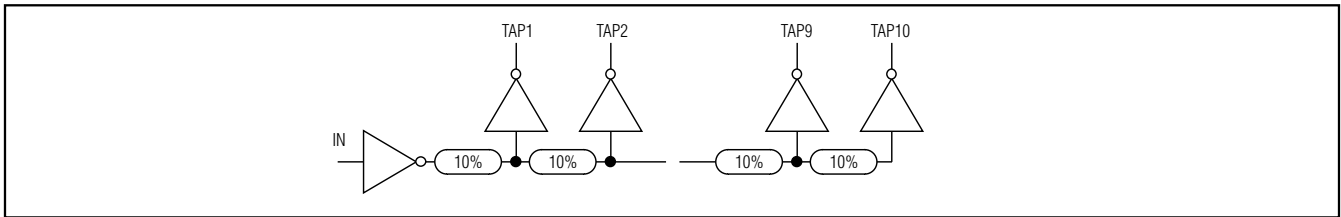


Figure 1. Logic Diagram

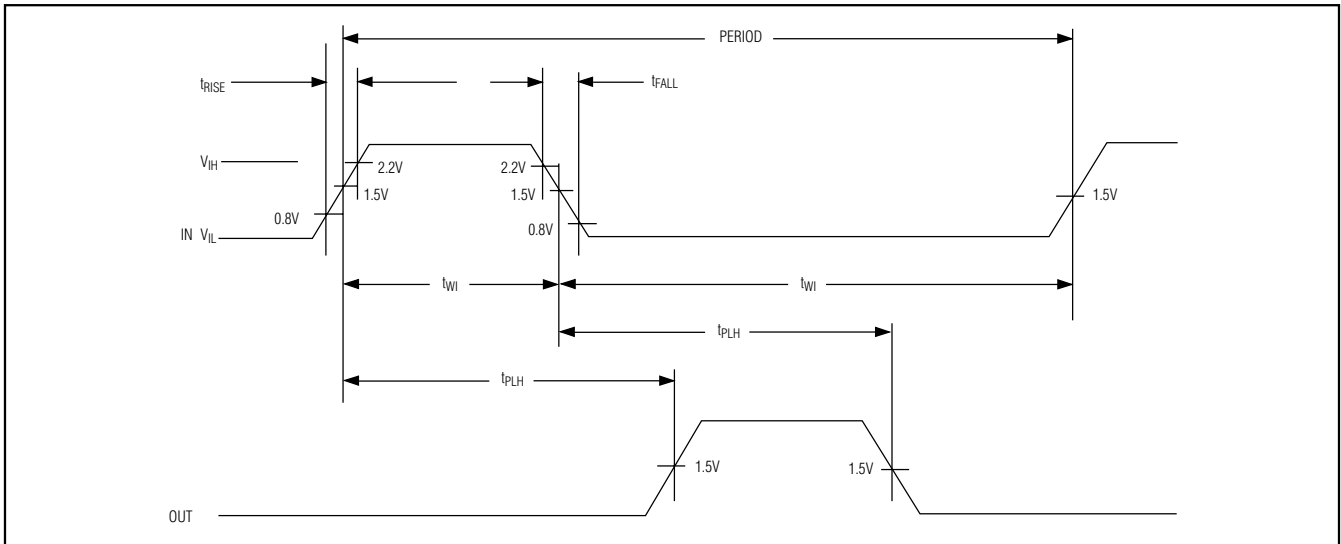


Figure 2. Timing Diagram: Silicon Delay Line

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Terminology

Period: The time elapsed between the leading edge of the first pulse and the leading edge of the following pulse.

tw_I (Pulse Width): The elapsed time on the pulse between the 1.5V point on the leading edge and the 1.5V point on the trailing edge, or the 1.5V point on the trailing edge and the 1.5V point on the leading edge.

t_{RISE} (Input Rise Time): The elapsed time between the 20% and the 80% point on the leading edge of the input pulse.

t_{FALL} (Input Fall Time): The elapsed time between the 80% and the 20% point on the trailing edge of the input pulse.

t_{PLH} (Time Delay, Rising): The elapsed time between the 1.5V point on the leading edge of the input pulse and the 1.5V point on the leading edge of any tap output pulse.

t_{PHL} (Time Delay, Falling): The elapsed time between the 1.5V point on the trailing edge of the input pulse and the 1.5V point on the trailing edge of any tap output pulse.

Test Setup Description

Figure 3 illustrates the hardware configuration used for measuring the timing parameters on the DS1110. A precision pulse generator under software control produces the input waveform. Time delays are measured by a time interval counter (20ps resolution) connected

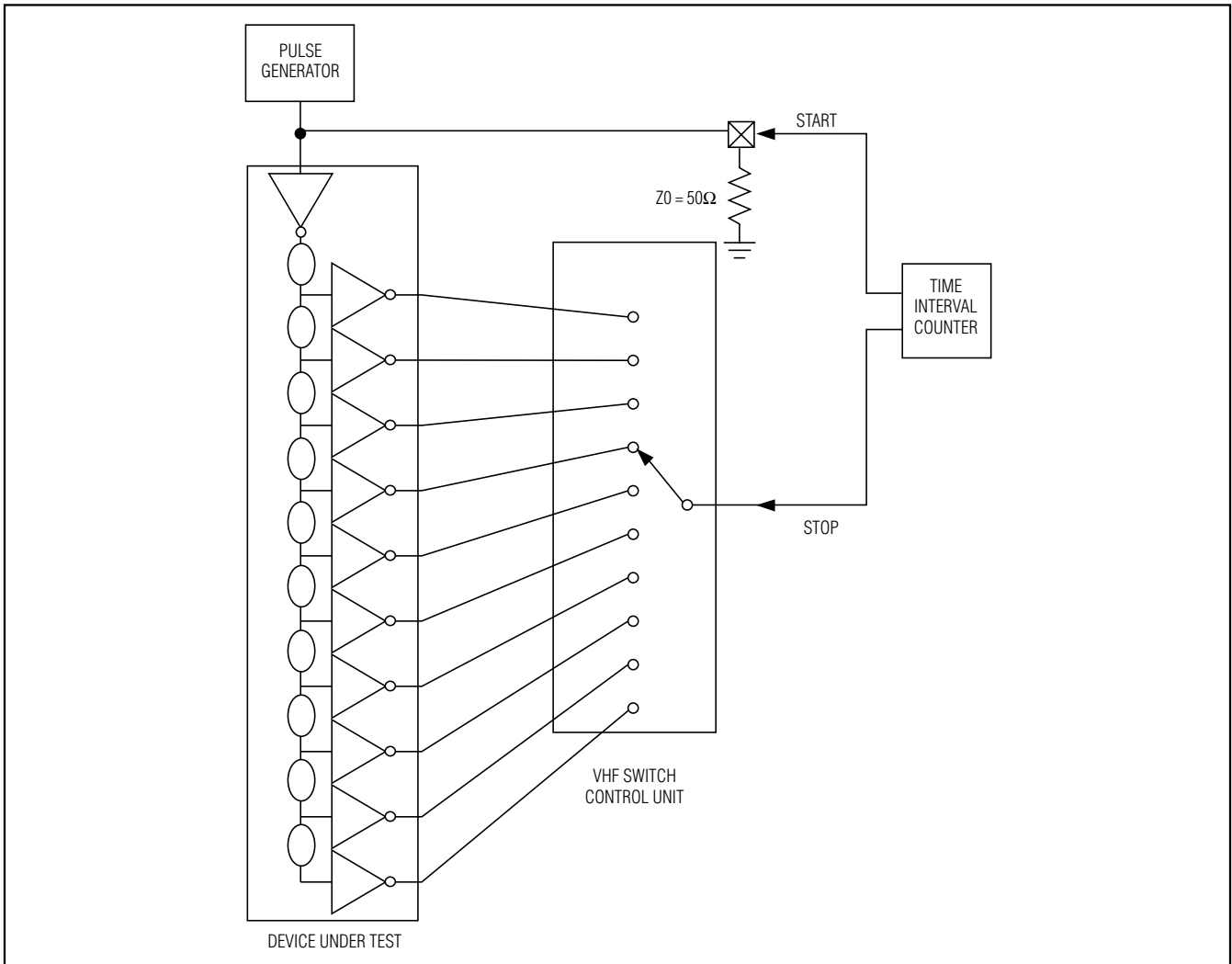


Figure 3. Test Circuit

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between the input and each tap. Each tap is selected and connected to the counter by a VHF switch-control unit. All measurements are fully automated, with each instrument controlled by a central computer over an IEEE-488 bus.

Output

Each output is loaded with the equivalent of one 74FO4 input gate. Delay is measured at the 1.5V level on the rising and falling edge.

Chip Information

TRANSISTOR COUNT: 6813

Table 2. Test Conditions

| INPUT | CONDITION |
|-----------------------------------|------------------------|
| Ambient Temperature | +25°C ±3°C |
| Supply Voltage (V _{CC}) | 5.0V ±0.1V |
| Input Pulse | High = 3.0V ±0.1V |
| | Low = 0.0V ±0.1V |
| Source Impedance | 50Ω max |
| Rise and Fall Time | 3ns max |
| Pulse Width | 500ns (1μs for -500ns) |
| Period | 1μs (2μs for -500ns) |

Note: The above conditions are for test only and do not restrict the operation of the device under other data sheet conditions.

Selector Guide

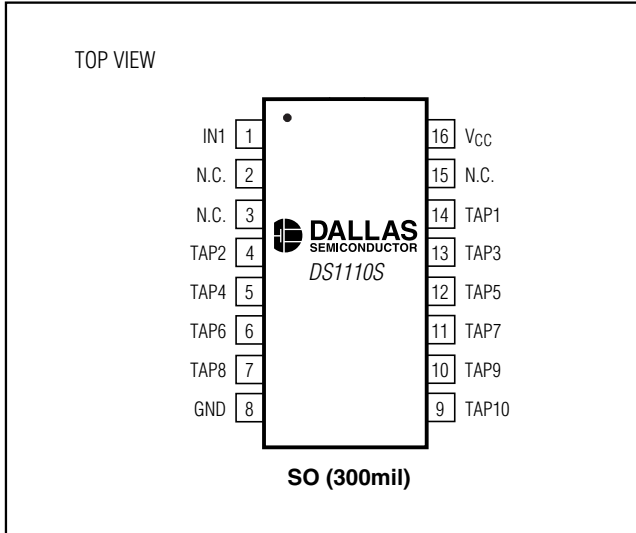
| PART | TEMP RANGE | PIN-PACKAGE | TOTAL DELAY (ns)* |
|-------------|----------------|-------------|-------------------|
| DS1110E-50 | -40°C to +85°C | 14 TSSOP | 50 |
| DS1110E-60 | -40°C to +85°C | 14 TSSOP | 60 |
| DS1110E-75 | -40°C to +85°C | 14 TSSOP | 75 |
| DS1110E-80 | -40°C to +85°C | 14 TSSOP | 80 |
| DS1110E-100 | -40°C to +85°C | 14 TSSOP | 100 |
| DS1110E-125 | -40°C to +85°C | 14 TSSOP | 125 |
| DS1110E-150 | -40°C to +85°C | 14 TSSOP | 150 |
| DS1110E-175 | -40°C to +85°C | 14 TSSOP | 175 |
| DS1110E-200 | -40°C to +85°C | 14 TSSOP | 200 |
| DS1110E-250 | -40°C to +85°C | 14 TSSOP | 250 |
| DS1110E-300 | -40°C to +85°C | 14 TSSOP | 300 |
| DS1110E-350 | -40°C to +85°C | 14 TSSOP | 350 |
| DS1110E-400 | -40°C to +85°C | 14 TSSOP | 400 |
| DS1110E-450 | -40°C to +85°C | 14 TSSOP | 450 |
| DS1110E-500 | -40°C to +85°C | 14 TSSOP | 500 |

| PART | TEMP RANGE | PIN-PACKAGE | TOTAL DELAY (ns)* |
|-------------|----------------|-------------|-------------------|
| DS1110S-50 | -40°C to +85°C | 16 SO | 50 |
| DS1110S-60 | -40°C to +85°C | 16 SO | 60 |
| DS1110S-75 | -40°C to +85°C | 16 SO | 75 |
| DS1110S-80 | -40°C to +85°C | 16 SO | 80 |
| DS1110S-100 | -40°C to +85°C | 16 SO | 100 |
| DS1110S-125 | -40°C to +85°C | 16 SO | 125 |
| DS1110S-150 | -40°C to +85°C | 16 SO | 150 |
| DS1110S-175 | -40°C to +85°C | 16 SO | 175 |
| DS1110S-200 | -40°C to +85°C | 16 SO | 200 |
| DS1110S-250 | -40°C to +85°C | 16 SO | 250 |
| DS1110S-300 | -40°C to +85°C | 16 SO | 300 |
| DS1110S-350 | -40°C to +85°C | 16 SO | 350 |
| DS1110S-400 | -40°C to +85°C | 16 SO | 400 |
| DS1110S-450 | -40°C to +85°C | 16 SO | 450 |
| DS1110S-500 | -40°C to +85°C | 16 SO | 500 |

*Custom delays are available.

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Pin Configurations (continued)



Package Information

For the latest package outline information, go to www.maxim-ic.com/packages.

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